1 Features

- 16-bit performance: 1-LSB INL and DNL (max)
- Low glitch energy: 4 nV–s
- Wide power supply: 2.7 V to 5.5 V
- Buffered output range: 5 V, 2.5 V, or 1.25 V
- Very-low power: 1 mA at 5.5 V
- Integrated 5-ppm/˚C (max), 2.5-V precision reference
- Pin-selectable serial interface:
  - 3-wire, SPI compatible up to 50-MHz
  - 2-wire, I2C compatible
- Power-on-reset: Zero scale or midscale
- 1.62-V VIH with VDD = 5.5 V
- Temperature range: –40˚C to +125˚C
- Packages: Small 8-Pin WSON and 10-Pin VSSOP

2 Applications

- Oscilloscope (DSO)
- Semiconductor test
- Data acquisition (DAQ)
- LCD test
- Small cell base station
- Analog output module
- Process analytics (pH, gas, concentration, force and humidity)
- DC power supply, ac source, electronic load

3 Description

The 16-bit DAC80501, 14-bit DAC70501, and 12-bit DAC60501 (DACx0501) digital-to-analog converters (DACs) are highly accurate, low-power devices with voltage-output. The DACx0501 are specified monotonic by design, and offer linearity of < 1 LSB. These devices include a 2.5-V, 5-ppm/˚C internal reference, giving full-scale output voltage ranges of 1.25 V, 2.5 V, or 5 V. The DACx0501 incorporate a power-on-reset circuit that makes sure the DAC output powers up at zero scale or midscale, and remains at that scale until a valid code is written to the device. These devices consume a low current of 1 mA, and include a power-down feature that reduces current consumption to typically 15 µA at 5 V.

The digital interface of the DACx0501 can be configured to SPI or I2C mode using the SPI2C pin. In SPI mode, the DACx0501 use a versatile 3-wire serial interface that operates at clock rates of up to 50 MHz. In I2C mode, the DACx0501 operate in standard (100 kbps), fast (400 kbps), and fast+ (1.0 Mbps) modes.

The DACx0501 are available in easy-to-assemble 10-pin VSSOP and small 2-mm × 2-mm, 8-pin WSON packages. The devices are fully specified over the industrial temperature range of –40˚C to +125˚C.

Device Information

<table>
<thead>
<tr>
<th>PART NUMBER</th>
<th>PACKAGE</th>
<th>BODY SIZE (NOM)</th>
</tr>
</thead>
<tbody>
<tr>
<td>DAC80501</td>
<td>WSON (8)</td>
<td>2.00 mm × 2.00 mm</td>
</tr>
<tr>
<td>DAC70501</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DAC60501</td>
<td>VSSOP (10)(2)</td>
<td>3.00 mm × 3.00 mm</td>
</tr>
</tbody>
</table>

(1) For all available packages, see the package option addendum at the end of the data sheet.
(2) VSSOP package is preview.

Offset Trimming With the DACx0501

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.
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4 Revision History
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (August 2019) to Revision B Page

  • Changed DAC70501 and DAC60501 devices from preview to production data (active) ....................................................... 1

Changes from Original (November 2018) to Revision A Page

  • Changed DAC80501 in DQF (WSON) package from advanced information (preview) to production data (active) ............ 1
5 Device Comparison Table

<table>
<thead>
<tr>
<th>DEVICE</th>
<th>RESOLUTION</th>
<th>REFERENCE</th>
<th>POWER-ON RESET</th>
</tr>
</thead>
<tbody>
<tr>
<td>DAC80501Z</td>
<td>16-Bit</td>
<td>Internal (default) or External</td>
<td>Zero Scale</td>
</tr>
<tr>
<td>DAC80501M</td>
<td>16-Bit</td>
<td>Internal (default) or External</td>
<td>Midscale</td>
</tr>
<tr>
<td>DAC70501Z</td>
<td>14-Bit</td>
<td>Internal (default) or External</td>
<td>Zero Scale</td>
</tr>
<tr>
<td>DAC70501M</td>
<td>14-Bit</td>
<td>Internal (default) or External</td>
<td>Midscale</td>
</tr>
<tr>
<td>DAC60501Z</td>
<td>12-Bit</td>
<td>Internal (default) or External</td>
<td>Zero Scale</td>
</tr>
<tr>
<td>DAC60501M</td>
<td>12-Bit</td>
<td>Internal (default) or External</td>
<td>Midscale</td>
</tr>
</tbody>
</table>

6 Pin Configuration and Functions

Pin Functions

<table>
<thead>
<tr>
<th>PIN</th>
<th>TYPE</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>AGND</td>
<td>DGS 4</td>
<td>DQF 3 Ground reference point for all circuitry on the device.</td>
</tr>
<tr>
<td>NC</td>
<td>DGS 3</td>
<td>DQF — No connection. Leave floating.</td>
</tr>
<tr>
<td>NC</td>
<td>DGS 9</td>
<td>DQF — No connection. Leave floating.</td>
</tr>
<tr>
<td>SCLK/SCL</td>
<td>DGS 6</td>
<td>DQF 5 Serial interface clock. SPI or I²C mode.</td>
</tr>
<tr>
<td>SDIN/SDA</td>
<td>DGS 8</td>
<td>DQF 7 Input/output. SPI mode: Serial interface data input. Data are clocked into the input shift register on each falling edge of the SCLK pin. I²C mode: Data are clocked into or out of the input register. This pin is a bidirectional, SDA drain data line that must be connected to the supply voltage with an external pullup resistor.</td>
</tr>
<tr>
<td>SPI2C</td>
<td>DGS 5</td>
<td>DQF 4 Input Interface select pin. Digital interface in SPI mode if SPI2C = 0 Digital interface in I²C mode if SPI2C = 1 SPI2C pin must be kept static after device powers up.</td>
</tr>
<tr>
<td>SYNC/A0</td>
<td>DGS 7</td>
<td>DQF 6 Input SPI mode: Active low serial data enable. This input is the frame synchronization signal for the serial data. When the signal goes low, the serial interface input shift register is enabled. I²C mode: Four-state address input 0.</td>
</tr>
<tr>
<td>VDD</td>
<td>DGS 1</td>
<td>DQF 1 Power Analog supply voltage (2.7 V to 5.5 V)</td>
</tr>
<tr>
<td>VOUT</td>
<td>DGS 2</td>
<td>DQF 2 Output Analog output voltage from the DAC</td>
</tr>
<tr>
<td>VREFIO</td>
<td>DGS 10</td>
<td>DQF 8 Input/output When using the internal reference, this pin is the reference output voltage pin (default). Reference input to the device when operating with external reference.</td>
</tr>
</tbody>
</table>
7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)\(^{(1)}\)

<table>
<thead>
<tr>
<th>Input voltage</th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>VDD to AGND</td>
<td>0.3</td>
<td>6</td>
<td>V</td>
</tr>
<tr>
<td>VREFIO to AGND</td>
<td>0.3</td>
<td>VDD + 0.3</td>
<td></td>
</tr>
<tr>
<td>Digital input(s) to AGND</td>
<td>0.3</td>
<td>VDD + 0.3</td>
<td></td>
</tr>
<tr>
<td>Output voltage</td>
<td>VOUT to AGND</td>
<td>0.3</td>
<td>VDD + 0.3</td>
</tr>
<tr>
<td>Input current</td>
<td>Current into any pin</td>
<td>–10</td>
<td>10</td>
</tr>
<tr>
<td>Temperature</td>
<td>Junction temperature (T_J)</td>
<td>–40</td>
<td>150</td>
</tr>
<tr>
<td>Storage temperature (T_{stg})</td>
<td>–65</td>
<td>150</td>
<td></td>
</tr>
</tbody>
</table>

\(^{(1)}\) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

<table>
<thead>
<tr>
<th>(V_{(ESD)})</th>
<th>Electrostatic discharge</th>
<th>VALUE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(^{(1)})</td>
<td>±2000</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Charged device model (CDM), per JEDEC specification JESD22-C101, all pins(^{(2)})</td>
<td>±1000</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

\(^{(1)}\) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

\(^{(2)}\) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th>POWER SUPPLY</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>VDD to AGND</td>
<td>2.7</td>
<td>5.5</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>DIGITAL INPUTS</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VIH</td>
<td>1.62</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>VIL</td>
<td>0.45</td>
<td>V</td>
<td></td>
<td></td>
</tr>
<tr>
<td>REFERENCE INPUT</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VREFIO to AGND</td>
<td>1.2</td>
<td>0.5 × (VDD – 0.2)</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>VREFIO to AGND</td>
<td>2.4</td>
<td>(VDD – 0.2)</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>VREFIO to AGND</td>
<td>1.2</td>
<td>0.5 × VDD</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>VREFIO to AGND</td>
<td>2.4</td>
<td>VDD</td>
<td>V</td>
<td></td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>TEMPERATURE</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>(T_A)</td>
<td>–40</td>
<td>125</td>
<td>°C</td>
<td></td>
</tr>
</tbody>
</table>
7.4 Thermal Information

<table>
<thead>
<tr>
<th>THERMAL METRIC(1)</th>
<th>DACx0501</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>DGS (VSSOP)</td>
<td>DQF (WSON)</td>
</tr>
<tr>
<td></td>
<td>10 PINS</td>
<td>8 PINS</td>
</tr>
<tr>
<td>$R_{JA}$</td>
<td>Junction-to-ambient thermal resistance</td>
<td>170.1</td>
</tr>
<tr>
<td>$R_{JC(top)}$</td>
<td>Junction-to-case (top) thermal resistance</td>
<td>60.5</td>
</tr>
<tr>
<td>$R_{JB}$</td>
<td>Junction-to-board thermal resistance</td>
<td>92.6</td>
</tr>
<tr>
<td>$\Psi_{JT}$</td>
<td>Junction-to-top characterization parameter</td>
<td>7.8</td>
</tr>
<tr>
<td>$\Psi_{JB}$</td>
<td>Junction-to-board characterization parameter</td>
<td>90.7</td>
</tr>
</tbody>
</table>

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

7.5 Electrical Characteristics

All minimum and maximum values at $T_A = -40°C$ to $+125°C$ and all typical values at $T_A = 25°C$, $2.7 \leq VDD \leq 5.5$ V, external or internal VREFIO = 1.25 V to 5.5 V, $R_{LOAD} = 2$ kΩ to AGND, $C_{LOAD} = 200$ pF to AGND, and digital inputs at VDD or AGND (unless otherwise noted)

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>STATIC PERFORMANCE</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Resolution</td>
<td>DAC80501</td>
<td>16</td>
<td></td>
<td>Bits</td>
<td></td>
</tr>
<tr>
<td></td>
<td>DAC70501</td>
<td>14</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>DAC60501</td>
<td>12</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>INL</td>
<td>Integral nonlinearity(1)</td>
<td>DAC80501</td>
<td>1</td>
<td></td>
<td>LSB</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC70501</td>
<td>1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DNL</td>
<td>Differential nonlinearity(1)</td>
<td>DAC80501</td>
<td>1</td>
<td></td>
<td>LSB</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC70501</td>
<td>1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>TUE</td>
<td>Total unadjusted error(1)</td>
<td>DAC80501, reference divider disabled (REF-DIV bit = 0)</td>
<td>-0.08</td>
<td>-0.02</td>
<td>0.08</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC80501, reference divider enabled (REF-DIV bit = 1)</td>
<td>-0.06</td>
<td>0.025</td>
<td>0.06</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC70501, DAC60501</td>
<td>-0.1</td>
<td>0.04</td>
<td>0.1</td>
</tr>
<tr>
<td>Zero code error(1)</td>
<td>DAC loaded with zero scale code</td>
<td>-1.5</td>
<td>0.5</td>
<td>1.5</td>
<td>mV</td>
</tr>
<tr>
<td>Offset error(1)</td>
<td>DAC loaded with zero scale code</td>
<td>-1.5</td>
<td>0.5</td>
<td>1.5</td>
<td>mV</td>
</tr>
<tr>
<td>Offset error temperature coefficient (1)</td>
<td></td>
<td></td>
<td>±2</td>
<td>µV/°C</td>
<td></td>
</tr>
<tr>
<td>Gain error(1)</td>
<td>DAC80501, reference divider disabled (REF-DIV bit = 0)</td>
<td>-0.08</td>
<td>-0.02</td>
<td>0.08</td>
<td>%FSR</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC80501, reference divider enabled (REF-DIV bit = 1)</td>
<td>-0.06</td>
<td>0.025</td>
<td>0.06</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC70501, DAC60501</td>
<td>-0.1</td>
<td>0.04</td>
<td>0.1</td>
</tr>
<tr>
<td>Gain error temperature coefficient (1)</td>
<td></td>
<td></td>
<td>±1</td>
<td>ppm FSR/°C</td>
<td></td>
</tr>
<tr>
<td>Full-scale error(1)</td>
<td>DAC80501, DAC loaded with full scale, reference divider disabled (REF-DIV bit = 0)</td>
<td>-0.08</td>
<td>-0.02</td>
<td>0.08</td>
<td>%FSR</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC80501, DAC loaded with full scale, reference divider enabled (REF-DIV bit = 1)</td>
<td>-0.06</td>
<td>0.025</td>
<td>0.06</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC70501, DAC60501</td>
<td>-0.1</td>
<td>0.04</td>
<td>0.1</td>
</tr>
<tr>
<td>Full-scale error temperature coefficient (1)</td>
<td></td>
<td></td>
<td>±2</td>
<td>ppm FSR/°C</td>
<td></td>
</tr>
</tbody>
</table>

(1) End point fit between code 256 to code 64,511 for 16-bit, code 64 to code 16,127 for 14-bit, code 16 to code 4031 for 12 bit, DAC output unloaded, performance under resistive and capacitice load conditions are specified by design and characterization, DAC output range $\geq$ 2.5 V.
### Electrical Characteristics (continued)

All minimum and maximum values at $T_A = -40°C$ to $+125°C$ and all typical values at $T_A = 25°C$, $2.7 \text{ V} \leq VDD \leq 5.5 \text{ V}$, external or internal $VREFIO = 1.25 \text{ V}$ to $5.5 \text{ V}$, $R_{LOAD} = 2 \text{ kΩ}$ to AGND, $C_{LOAD} = 200 \text{ pF}$ to AGND, and digital inputs at VDD or AGND (unless otherwise noted).

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>OUTPUT CHARACTERISTICS</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$V_O$</td>
<td>Output voltage</td>
<td>BUFF-GAIN bit set to 1, REF-DIV bit set to 0</td>
<td>0</td>
<td>$2 \times VREFIO$</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>BUFF-GAIN bit set to 1, REF-DIV bit set to 1</td>
<td>0</td>
<td>$VREFIO$</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>BUFF-GAIN bit set to 0, REF-DIV bit set to 1</td>
<td>0</td>
<td>$0.5 \times VREFIO$</td>
<td></td>
</tr>
<tr>
<td>$R_{LOAD}$</td>
<td>Resistive load (2)</td>
<td>$VDD = 2.7 \text{ V}$</td>
<td>0.25</td>
<td></td>
<td>kΩ</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$VDD = 5.5 \text{ V}$</td>
<td>0.5</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$C_{LOAD}$</td>
<td>Capacitive load (2)</td>
<td>$R_{LOAD} = \infty$</td>
<td>2</td>
<td></td>
<td>nF</td>
</tr>
<tr>
<td></td>
<td></td>
<td>$R_{LOAD} = 2 \text{ kΩ}$</td>
<td>10</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Load regulation</td>
<td></td>
<td>DAC at midscale, $-10 \text{ mA} \leq I_{OUT} \leq 10 \text{ mA}$</td>
<td>80</td>
<td></td>
<td>µV/mA</td>
</tr>
<tr>
<td>Short circuit current</td>
<td>Full scale output shorted to AGND</td>
<td>30</td>
<td></td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Zero output shorted to VDD</td>
<td>30</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Output voltage headroom</td>
<td>to VDD, DAC at full code, $I_{OUT} = 10 \text{ mA}$</td>
<td>0.3</td>
<td>0.1</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Output voltage footroom</td>
<td>to AGND, DAC at zero code, $I_{OUT} = 10 \text{ mA}$</td>
<td>0.3</td>
<td></td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>$Z_O$</td>
<td>DC small signal output impedance</td>
<td>DAC at midscale</td>
<td>0.1</td>
<td></td>
<td>Ω</td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC at code 256</td>
<td>10</td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>DAC at code 65279</td>
<td>10</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Power supply rejection ratio (DC)</td>
<td>DAC at midscale; VDD = 5 V ± 10%</td>
<td>0.15</td>
<td></td>
<td>mV/V</td>
<td></td>
</tr>
<tr>
<td>Output voltage drift vs time</td>
<td>$T_A = 35°C$, VOUT = midscale, 1900 hr</td>
<td>20</td>
<td></td>
<td>ppm of FSR</td>
<td></td>
</tr>
<tr>
<td><strong>VOLTAGE REFERENCE INPUT</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
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</tr>
<tr>
<td>$Z_{VREFIO}$</td>
<td>Reference input impedance ($VREFIO$)</td>
<td></td>
<td>100</td>
<td></td>
<td>kΩ</td>
</tr>
<tr>
<td>$C_{VREFIO}$</td>
<td>Reference input capacitance ($VREFIO$)</td>
<td></td>
<td>5</td>
<td></td>
<td>pF</td>
</tr>
<tr>
<td><strong>VOLTAGE REFERENCE OUTPUT</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Output (initial accuracy) (3)</td>
<td>$T_A = 25°C$</td>
<td>2.4975</td>
<td>2.5025</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Output drift (3)</td>
<td>DAC80501</td>
<td>5</td>
<td></td>
<td>ppm/°C</td>
<td></td>
</tr>
<tr>
<td></td>
<td>DAC70501, DAC60501</td>
<td>10</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Output impedance (3)</td>
<td></td>
<td>0.1</td>
<td></td>
<td>Ω</td>
<td></td>
</tr>
<tr>
<td>Output noise (3)</td>
<td>0.1 Hz to 10 Hz</td>
<td>14</td>
<td></td>
<td>µVpp</td>
<td></td>
</tr>
<tr>
<td>Output noise density (3)</td>
<td>Measured at 10 kHz, reference load = 10 nF</td>
<td>140</td>
<td></td>
<td>nV/√Hz</td>
<td></td>
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<tr>
<td>Load current (3)</td>
<td></td>
<td>±5</td>
<td></td>
<td>mA</td>
<td></td>
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<tr>
<td>Load regulation (3)</td>
<td>Sourcing and sinking</td>
<td>90</td>
<td></td>
<td>µV/mA</td>
<td></td>
</tr>
<tr>
<td>Line regulation (3)</td>
<td></td>
<td>20</td>
<td></td>
<td>µV/V</td>
<td></td>
</tr>
<tr>
<td>Output voltage drift vs time (3)</td>
<td>$T_A = 35°C$, 1900 hr</td>
<td>20</td>
<td></td>
<td>µV</td>
<td></td>
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<td>Thermal hysteresis (3)</td>
<td>1st cycle</td>
<td>500</td>
<td></td>
<td>µV</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Additional cycle</td>
<td>25</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

(2) Not production tested.
(3) Characterized on 8-pin DQF package.
## Electrical Characteristics (continued)

All minimum and maximum values at $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$ and all typical values at $T_A = 25^\circ\text{C}$, $2.7\ \text{V} \leq \text{VDD} \leq 5.5\ \text{V}$, external or internal VREFIO = 1.25 V to 5.5 V, $R_{\text{LOAD}} = 2\ \text{k}\Omega$ to AGND, $C_{\text{LOAD}} = 200\ \text{pF}$ to AGND, and digital inputs at VDD or AGND (unless otherwise noted).

<table>
<thead>
<tr>
<th>PARAMETER</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$t_s$</td>
<td>Output voltage settling time (4)</td>
<td>$\frac{1}{4}$ to $\frac{3}{4}$ scale and $\frac{3}{4}$ to $\frac{1}{4}$ scale settling to $\pm 2$ LSB, $\text{VDD} = 5.5\ \text{V}$, $\text{VREFIO} = 2.5\ \text{V}$</td>
<td>5</td>
<td>μs</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>10-mV settling to $\pm 2$ LSB, $\text{VDD} = 5.5\ \text{V}$, $\text{VREFIO} = 2.5\ \text{V}$</td>
<td>3</td>
<td>μs</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Slew rate (4)</td>
<td>$\text{VDD} = 5.5\ \text{V}$, $\text{VREFIO} = 2.5\ \text{V}$</td>
<td>2</td>
<td>V/μs</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Power on glitch magnitude</td>
<td>$C_{\text{LOAD}} = 50\ \text{pF}$</td>
<td>200</td>
<td>mV</td>
<td></td>
</tr>
<tr>
<td>$V_n$</td>
<td>Output noise (4)</td>
<td>0.1 Hz to 10 Hz, DAC at midscale, $\text{VDD} = 5.5\ \text{V}$, external $\text{VREFIO} = 2.5\ \text{V}$</td>
<td>14</td>
<td>μV&lt;sub&gt;pp&lt;/sub&gt;</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>100-kHz Bandwidth, DAC at midscale, $\text{VDD} = 5.5\ \text{V}$, external $\text{VREFIO} = 2.5\ \text{V}$</td>
<td>23</td>
<td>μV&lt;sub&gt;rms&lt;/sub&gt;</td>
<td></td>
</tr>
<tr>
<td>$V_n$</td>
<td>Output noise density</td>
<td>Measured at 1 kHz, DAC at midscale, $\text{VDD} = 5.5\ \text{V}$, external $\text{VREFIO} = 2.5\ \text{V}$, gain = 2X (BUFF-GAIN bit = 1)</td>
<td>78</td>
<td>nV/√Hz</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>Measured at 10 kHz, DAC at midscale, $\text{VDD} = 5.5\ \text{V}$, external $\text{VREFIO} = 2.5\ \text{V}$, gain = 2X (BUFF-GAIN bit = 1)</td>
<td>74</td>
<td>nV/√Hz</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>Measured at 1 kHz, DAC at full scale, $\text{VDD} = 2.7\ \text{V}$, external $\text{VREFIO} = 2.5\ \text{V}$, gain = 1X (BUFF-GAIN bit = 0)</td>
<td>55</td>
<td>nV/√Hz</td>
<td></td>
</tr>
<tr>
<td></td>
<td></td>
<td>Measured at 10 kHz, DAC at full scale, $\text{VDD} = 2.7\ \text{V}$, external $\text{VREFIO} = 2.5\ \text{V}$, gain = 1X (BUFF-GAIN bit = 0)</td>
<td>50</td>
<td>nV/√Hz</td>
<td></td>
</tr>
<tr>
<td>SFDR</td>
<td>Spurious free dynamic range</td>
<td>1-kHz sinusoid at DAC output, DAC updated at 500 kHz, include up to 7th harmonics, no filter on DAC output</td>
<td>70</td>
<td>dB</td>
<td></td>
</tr>
<tr>
<td>THD</td>
<td>Total harmonic distortion</td>
<td>1-kHz sinusoid at DAC output, DAC updated at 500 kHz, include up to 7th harmonics, no filter on DAC output</td>
<td>70</td>
<td>dB</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Power supply rejection ratio (ac)</td>
<td>200-mV 50-Hz to 60-Hz sine wave superimposed on power supply voltage, DAC at midscale. (ac analysis)</td>
<td>85</td>
<td>dB</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Code change glitch impulse</td>
<td>Midcode $\pm 1$ LSB (including feedthrough)</td>
<td>4</td>
<td>nV·s</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Code change glitch magnitude</td>
<td>Midcode $\pm 1$ LSB (including feedthrough) gain = 1X (BUFF-GAIN bit = 0)</td>
<td>7.5</td>
<td>mV</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Digital feedthrough</td>
<td>At SCLK = 1 MHz, DAC output at midscale</td>
<td>4</td>
<td>nV·s</td>
<td></td>
</tr>
</tbody>
</table>

### Digital Inputs

| Hysteresis voltage | 0.4 | V |
| Input current | $-5$ to $5$ | &mu;A |
| Pin capacitance | Per pin | 10 | pF |

### Power Requirements

| $I_{\text{VDD}}$ | Current flowing into VDD | Normal mode, internal reference enabled, DAC at full scale, SPI static | 1.5 | 2.0 | mA |
| | | Normal mode, external reference = 2.5 V, DAC at full scale, SPI static | 1 | 1.4 | mA |
| | DAC and internal reference power-down | 15 | &mu;A |
| $I_{\text{VREFIO}}$ | Current flowing into VREFIO | 0-V to 5-V range, midscale code | 25 | &mu;A |

(4) Output buffer in gain = 2X setting (BUFF-GAIN bit = 1).
7.6 Timing Requirements : SPI Mode

All input signals are specified with $t_R = t_F = 1 \text{ ns/V}$ and timed from a voltage level of $(V_{IL} + V_{IH}) / 2$. $2.7 \text{ V} \leq VDD \leq 5.5 \text{ V}$, $V_{IH} = 1.62 \text{ V}$, $V_{IL} = 0.15 \text{ V}$, $VREFIO = 1.25 \text{ V}$ to $5.5 \text{ V}$, and $T_A = -40^\circ \text{C}$ to $+125^\circ \text{C}$ (unless otherwise noted)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$f_SCLK$</td>
<td></td>
<td></td>
<td>50</td>
<td>MHz</td>
</tr>
<tr>
<td>$t_{SCLKHIGH}$</td>
<td></td>
<td></td>
<td>9</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SCLKLOW}$</td>
<td></td>
<td></td>
<td>9</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SDIS}$</td>
<td></td>
<td></td>
<td>5</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SDIH}$</td>
<td></td>
<td></td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SYNCS}$</td>
<td></td>
<td></td>
<td>13</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SYNCH}$</td>
<td></td>
<td></td>
<td>10</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SYNCHIGH}$</td>
<td></td>
<td></td>
<td>160</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SYNCIGNOR}$</td>
<td></td>
<td></td>
<td>15</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{DACWAIT}$</td>
<td>1</td>
<td></td>
<td></td>
<td>$\mu$s</td>
</tr>
</tbody>
</table>

7.7 Timing Requirements : I²C Standard Mode

All input signals are specified with $t_R = t_F = 1 \text{ ns/V}$ and timed from a voltage level of $(V_{IL} + V_{IH}) / 2$. $2.7 \text{ V} \leq VDD \leq 5.5 \text{ V}$, $V_{IH} = 1.62 \text{ V}$, $V_{IL} = 0.45 \text{ V}$, $VREFIO = 1.25 \text{ V}$ to $5.5 \text{ V}$, and $T_A = -40^\circ \text{C}$ to $+125^\circ \text{C}$ (unless otherwise noted)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>$f_{SCLK}$</td>
<td></td>
<td></td>
<td>0.1</td>
<td>MHz</td>
</tr>
<tr>
<td>$t_{BUF}$</td>
<td></td>
<td></td>
<td>4.7</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{HDSTA}$</td>
<td></td>
<td></td>
<td>4</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{SUSTA}$</td>
<td></td>
<td></td>
<td>4.7</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{SUSTO}$</td>
<td></td>
<td></td>
<td>4</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{HDAT}$</td>
<td>0</td>
<td></td>
<td>250</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SUDAT}$</td>
<td></td>
<td></td>
<td>0</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{LOW}$</td>
<td></td>
<td></td>
<td>4700</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{HIGH}$</td>
<td></td>
<td></td>
<td>4000</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{R}$</td>
<td>300</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{F}$</td>
<td>1000</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{UPDATE}$</td>
<td>1</td>
<td></td>
<td></td>
<td>$\mu$s</td>
</tr>
</tbody>
</table>

7.8 Timing Requirements : I²C Fast Mode

All input signals are specified with $t_R = t_F = 1 \text{ ns/V}$ and timed from a voltage level of $(V_{IL} + V_{IH}) / 2$. $2.7 \text{ V} \leq VDD \leq 5.5 \text{ V}$, $V_{IH} = 1.62 \text{ V}$, $V_{IL} = 0.45 \text{ V}$, $VREFIO = 1.25 \text{ V}$ to $5.5 \text{ V}$, and $T_A = -40^\circ \text{C}$ to $+125^\circ \text{C}$ (unless otherwise noted)

<table>
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<tr>
<th>Parameter</th>
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</tr>
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<td>$t_{BUF}$</td>
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<td>1.3</td>
<td>$\mu$s</td>
</tr>
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<td>$t_{HDSTA}$</td>
<td></td>
<td></td>
<td>0.6</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{SUSTA}$</td>
<td></td>
<td></td>
<td>0.6</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{SUSTO}$</td>
<td></td>
<td></td>
<td>0.6</td>
<td>$\mu$s</td>
</tr>
<tr>
<td>$t_{HDAT}$</td>
<td>0</td>
<td></td>
<td>100</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{SUDAT}$</td>
<td></td>
<td></td>
<td>100</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{LOW}$</td>
<td></td>
<td></td>
<td>1300</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{HIGH}$</td>
<td></td>
<td></td>
<td>600</td>
<td>ns</td>
</tr>
<tr>
<td>$t_{R}$</td>
<td>300</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{F}$</td>
<td>300</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>$t_{UPDATE}$</td>
<td>1</td>
<td></td>
<td></td>
<td>$\mu$s</td>
</tr>
</tbody>
</table>
7.9 Timing Requirements: I2C Fast-Mode Plus

all input signals are specified with \( t_R = t_F = 1 \text{ ns/V} \) and timed from a voltage level of \( (V_{IL} + V_{IH}) / 2 \). \( 2.7 \text{ V} \leq VDD \leq 5.5 \text{ V} \), \( V_{IH} = 1.62 \text{ V} \), \( V_{IL} = 0.45 \text{ V} \), \( V_{REFIO} = 1.25 \text{ V} \) to \( 5.5 \text{ V} \), and \( T_A = -40^\circ \text{C} \) to \( +125^\circ \text{C} \) (unless otherwise noted)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>( t_{SCLK} )</td>
<td></td>
<td></td>
<td>1</td>
<td>MHz</td>
</tr>
<tr>
<td>( t_{BUF} )</td>
<td></td>
<td></td>
<td>0.5</td>
<td>( \mu \text{ s} )</td>
</tr>
<tr>
<td>( t_{HDSTA} )</td>
<td></td>
<td></td>
<td>0.26</td>
<td>( \mu \text{ s} )</td>
</tr>
<tr>
<td>( t_{SUSTA} )</td>
<td></td>
<td></td>
<td>0.26</td>
<td>( \mu \text{ s} )</td>
</tr>
<tr>
<td>( t_{SUSTO} )</td>
<td></td>
<td></td>
<td>0.26</td>
<td>( \mu \text{ s} )</td>
</tr>
<tr>
<td>( t_{HDAT} )</td>
<td></td>
<td></td>
<td>0</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{SUDAT} )</td>
<td></td>
<td></td>
<td>50</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{LOW} )</td>
<td></td>
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<td>500</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{HIGH} )</td>
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<td>260</td>
<td>ns</td>
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<tr>
<td>( t_R )</td>
<td></td>
<td></td>
<td>120</td>
<td>ns</td>
</tr>
<tr>
<td>( t_F )</td>
<td></td>
<td></td>
<td>120</td>
<td>ns</td>
</tr>
<tr>
<td>( t_{UPDATE} )</td>
<td></td>
<td></td>
<td>1</td>
<td>( \mu \text{ s} )</td>
</tr>
</tbody>
</table>

---

Figure 1. SPI Mode Timing

Figure 2. I2C Mode Timing
7.10 Typical Characteristics

at $T_A = 25^\circ C$, VDD = 5.5 V, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)

---

Figure 3. Integral Linearity Error vs Digital Input Code

Figure 4. Differential Linearity Error vs Digital Input Code

Figure 5. Total Unadjusted Error vs Digital Input Code

Figure 6. Integral Linearity Error vs Temperature

Figure 7. Differential Linearity Error vs Temperature

Figure 8. Total Unadjusted Error vs Temperature
Typical Characteristics (continued)

at $T_A = 25^\circ C$, $VDD = 5.5 \text{ V}$, Internal reference $= 2.5 \text{ V}$, REF-DIV $= 0$ and BUFF-GAIN $= 1$, and DAC outputs unloaded (unless otherwise noted)

![Graphs showing Zero Code Error vs Temperature, Offset Error vs Temperature, Full Scale Error vs Temperature, Gain Error vs Temperature, Integral Linearity Error vs Supply Voltage, Differential Linearity Error vs Supply Voltage.](image-url)
Typical Characteristics (continued)

at $T_A = 25^\circ C$, $VDD = 5.5\, V$, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)
## Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, VDD = 5.5 V, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)

<table>
<thead>
<tr>
<th>V REFIN (V)</th>
<th>Zero Code Error (mV)</th>
<th>DNL (LSB)</th>
<th>Total Unadjusted Error (%FSR)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1.25</td>
<td>0.02</td>
<td>0.25</td>
<td>-0.08</td>
</tr>
<tr>
<td>2</td>
<td>0.04</td>
<td>0.5</td>
<td>-0.06</td>
</tr>
<tr>
<td>2.75</td>
<td>0.06</td>
<td>0.75</td>
<td>-0.04</td>
</tr>
<tr>
<td>3.5</td>
<td>0.08</td>
<td>1</td>
<td>-0.02</td>
</tr>
<tr>
<td>4.25</td>
<td>0.1</td>
<td>1.5</td>
<td>0</td>
</tr>
<tr>
<td>5</td>
<td>0.12</td>
<td>2</td>
<td>0.02</td>
</tr>
<tr>
<td>5.5</td>
<td>0.14</td>
<td>2.25</td>
<td>0.04</td>
</tr>
</tbody>
</table>

**Figure 21. Differential Linearity Error vs Reference Voltage**

**Figure 22. Total Unadjusted Error vs Reference Voltage**

**Figure 23. Zero Code Error vs Reference Voltage**

**Figure 24. Offset Error vs Reference Voltage**

**Figure 25. Gain Error vs Reference Voltage**

**Figure 26. Full Scale Error vs Reference Voltage**
Typical Characteristics (continued)

at $T_A = 25°C$, $VDD = 5.5\, V$, Internal reference = 2.5\, V, $\text{REF-DIV} = 0$ and $\text{BUFF-GAIN} = 1$, and DAC outputs unloaded (unless otherwise noted)

**Figure 27. Supply Current vs Digital Input Code**

**Figure 28. Supply Current vs Temperature**

**Figure 29. Supply Current vs Supply Voltage**

**Figure 30. Power Down Current vs Temperature**

**Figure 31. Power Down Current vs Supply Voltage**

**Figure 32. Headroom and Footroom vs Load Current**
Typical Characteristics (continued)

at $T_A = 25^\circ C$, $VDD = 5.5$ V, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)

| DAC code transition from midscale – 1 to midscale LSB, REF-DIV = 0 and BUFF-GAIN = 0 |
| DAC code transition from midscale to midscale – 1 LSB, REF-DIV = 0 and BUFF-GAIN = 0 |

| REF-DIV = 0 and BUFF-GAIN = 0 |
| REF-DIV = 0 and BUFF-GAIN = 1 |

| Figure 33. Source and Sink Capability |
| Figure 34. Source and Sink Capability |
| Figure 35. Source and Sink Capability |
| Figure 36. Glitch Impulse, Rising Edge, 1 LSB Step |
| Figure 37. Glitch Impulse, Falling Edge, 1 LSB Step |
| Figure 38. Full-Scale Settling Time, Rising Edge |

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Typical Characteristics (continued)

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Typical Characteristics (continued)

at $T_A = 25^\circ$C, $VDD = 5.5$ V, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)

**Figure 39. Full-Scale Settling Time, Falling Edge**

**Figure 40. Power-on Glitch**

**Figure 41. Power-off Glitch**

**Figure 42. DAC Output AC PSRR vs Frequency**

**Figure 43. DAC Output THD+N vs Frequency**

**Figure 44. DAC Output Noise Spectral Density**
Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, VDD = 5.5 V, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)

**Figure 45. DAC Output Noise 0.1 Hz to 10 Hz**

DAC code at midscale, external reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 0

**Figure 46. DAC Output Noise 0.1 Hz to 10 Hz**

DAC code at midscale, internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 0

**Figure 47. Clock Feedthrough**

SCLK = 1 MHz, DAC code at midscale, external reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 0

**Figure 48. Internal Reference Voltage vs Temperature**

**Figure 49. Internal Reference Voltage vs Supply Voltage**

**Figure 50. Internal Reference Voltage vs Time**
Typical Characteristics (continued)

at $T_A = 25^\circ C$, VDD = 5.5 V, Internal reference = 2.5 V, REF-DIV = 0 and BUFF-GAIN = 1, and DAC outputs unloaded (unless otherwise noted)

---

![Figure 51. Internal Reference Noise Density vs Frequency](image1)

![Figure 52. Internal Reference Noise, 0.1 Hz to 10 Hz](image2)

![Figure 53. Internal Reference Temperature Drift Histogram](image3)

![Figure 54. Internal Reference Initial Accuracy (Pre and Post Solder) Histogram](image4)

![Figure 55. Internal Reference Temperature Drift (Pre and Post Solder) Histogram](image5)
8 Detailed Description

8.1 Overview

The DAC80501, DAC70501, DAC60501 (DACx0501) family of devices are buffered voltage output, 16-bit, 14-bit, or 12-bit digital-to-analog converters (DACs), respectively. These devices include a 2.5-V, 5-ppm/°C internal reference, giving full-scale output voltage ranges of 1.25 V, 2.5 V, or 5 V. The DACx0501 devices incorporate a power-on-reset circuit that makes sure that the DAC output powers up at zero scale or midscale, and remains at that scale until a valid code is written to the device.

The digital interface of the DACx0501 can be configured to SPI or I²C mode using the SPI2C pin. In SPI mode, the DACx0501 family uses a 3-wire serial interface that operates at clock rates up to 50 MHz. In I²C mode, the DACx0501 devices operate in standard mode (100 kbps), fast mode (400 kbps), and fast mode plus (1.0 Mbps).

8.2 Functional Block Diagram

8.3 Feature Description

8.3.1 DAC Architecture

The output channel in the DACx0501 family of devices consists of a rail-to-rail ladder architecture with an output buffer amplifier. The devices include an internal 2.5-V reference. Figure 56 shows a block diagram of the DAC architecture.
Feature Description (continued)

8.3.1.1 DAC Transfer Function

The input data writes to the individual DAC data registers in straight binary format. After a power-on or a reset event, all DAC registers are set to zero code (DACx0501Z devices) or midscale code (DACx0501M devices). The DAC transfer function is shown by Equation 1.

\[
V_{OUT} = \frac{\text{DAC\_DATA} \times V_{REFIO}}{2^N} \times \text{DIV} \times \text{GAIN}
\]

where:
- \( N \) = resolution in bits = either 12 (DAC60501), 14 (DAC70501) or 16 (DAC80501).
- \( \text{DAC\_DATA} \) = decimal equivalent of the binary code that is loaded to the DAC register (address 8h). DAC\_DATA ranges from 0 to \( 2^N - 1 \).
- \( V_{REFIO} \) = DAC reference voltage at the VREFIO pin. Either VREFIO from the internal 2.5-V reference or VREFIO from an external reference.
- \( \text{DIV} \) = 1 (default) or 2, as set by the REF-DIV bit in the GAIN register (address 4h).
- \( \text{GAIN} \) = 1 or 2 (default), as set by the BUFF-GAIN bit in the GAIN register (address 4h).

8.3.1.2 DAC Register Structure

Data written to the DAC data registers are initially stored in the DAC buffer registers. The update mode of the DAC output is determined by the status of the DAC\_SYNC\_EN bit (address 2h).

In asynchronous mode (default, DAC\_SYNC\_EN = 0), a write to the DAC buffer register results in an immediate update of the DAC active register. In SPI mode, the DAC output (VOUT pin) updates on the rising edge of SYNC. In I\(^2\)C mode, the DAC output (VOUT pin) updates on the falling edge of SCL on the last acknowledge bit.

In synchronous mode (DAC\_SYNC\_EN = 1), writing to the DAC buffer register does not automatically update the DAC active register. Instead, the update occurs only after a software LDAC trigger event. A software LDAC trigger generates through the LDAC bit in the TRIGGER register (address 5h). When the host reads from a DAC buffer register, the value held in the DAC buffer register is returned (not the value held in the DAC active register).

8.3.1.3 Output Amplifier

The output buffer amplifier generates rail-to-rail voltages on the output, giving a maximum output range of 0 V to VDD. Equation 1 shows that the full-scale output range of the DAC output is determined by the voltage on the VREFIO pin, the reference divider setting (DIV) as set by the REF-DIV bit (address 4h), and the gain configuration for that channel set by the corresponding BUFF-GAIN bit (address 4h).

8.3.2 Internal Reference

The DAx0501 family of devices includes a 2.5-V precision band-gap reference that is enabled by default. Operation from an external reference is supported by disabling the internal reference in the REF\_PWDWN bit (address 3h). The internal reference is externally available at the VREFIO pin, and sources up to 5 mA. For noise filtering, use a minimum 150-nF capacitor between the reference output and AGND.

The reference voltage to the device, either from the internal reference or an external one, can be divided by a factor of two by setting the REF-DIV bit (address 4h) to 1. The REF-DIV bit provides additional flexibility in setting the full-scale output range of the DAC output. Make sure to configure REF-DIV so that there is sufficient headroom from VDD to the DAC operating reference voltage, VREFIO (see Equation 1). See the Recommended Operating Conditions for more information.

Improper configuration of the reference divider triggers a reference alarm condition. In this case, the reference buffer is shut down, and all the DAC outputs go to 0 V. The DAC data registers are unaffected by the alarm condition, thus enabling the DAC output to return to normal operation after the reference divider is configured correctly.
Feature Description (continued)

8.3.2.1 Solder Heat Reflow

A known behavior of IC reference voltage circuits is the shift induced by the soldering process. Figure 54 and Figure 55 show the effect of solder heat reflow for the DACx0501 internal reference.

8.3.3 Power-On-Reset (POR)

The DACx0501 family of devices includes a power-on reset (POR) function that controls the output voltage at power up. After the VDD supply has been established, a POR event is issued. The POR causes all registers to initialize to default values, and communication with the device is valid only after a 250-µs POR delay. The default value for the DAC data registers is zero-code for the DACx0501Z devices and midscale code for the DACx0501M devices. The DAC output remains at the power-up voltage until a valid command is written to a channel.

When the device powers up, a POR circuit sets the device to the default mode. The POR circuit requires specific VDD levels, as indicated in Figure 57, to make sure that the internal capacitors discharge and reset the device at power up. To make sure that a POR occurs, VDD must be less than 0.7 V for at least 1 ms. When VDD drops to less than 2.2 V but remains greater than 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power-supply conditions. In this case, initiate a POR. When VDD remains greater than 2.2 V, a POR does not occur.

8.3.4 Software Reset

A device software reset event is initiated by writing the reserved code 0x1010 to the SOFT-RESET bit in the TRIGGER register (address 5h). A software reset initiates a POR event.

---

**Figure 57. Threshold Levels for VDD POR Circuit**
8.4 Device Functional Modes
The DACx0501 has two modes of operation: normal and power-down.

8.4.1 Power-Down Mode
The DACx0501 output amplifiers and internal reference can be independently powered down through the CONFIG register (3h). At power up, the DAC output and the internal reference are active by default. In power-down mode, the DAC output (VOUT pin) is internally connected to AGND through a 1-kΩ resistor.

8.5 Programming

8.5.1 Serial Interface
The DACx0501 family of devices is controlled through either a 3-wire SPI or a 2-wire I²C interface. The type of interface is determined at device power up based on the logic level of the SPI2C pin. A logic 0 on the SPI2C pin puts the DACx0501 in SPI mode; whereas, logic 1 on SPI2C puts the DACx0501 in I²C mode. The SPI2C pin must be kept static after the device powers up.

8.5.1.1 SPI Mode
The DACx0501 digital interface is programmed to work in SPI mode when the logic level of the SPI2C pin is 0 at power up. In SPI mode, the DACx0501 have a 3-wire serial interface: SYNC, SCLK, and SDIN, as shown in the Pin Configuration and Functions section. The serial interface is compatible with SPI, QSPI, and Microwire interface standards, and most digital signal processors (DSPs). The serial interface operates at up to 50 MHz. The input shift register is 24 bits wide.

The serial clock SCLK is a continuous or a gated clock. The first falling edge of SYNC starts the operation cycle. When SYNC is high, the SCLK and SDIN signals are blocked. The device internal registers are updated from the shift register on the rising edge of SYNC.
Programming (continued)

8.5.1.1.1 **SYNC Interrupt**

For SPI mode operation, the **SYNC** line stays low for at least 24 falling edges of SCLK and the addressed DAC register updates on the **SYNC** rising edge. However, if the **SYNC** line is brought high before the 24th SCLK falling edge, this event acts as an interrupt to the write sequence. The shift register resets and the write sequence is discarded. Neither an update of the data buffer or DAC register contents, nor a change in the operating mode occurs, as shown in Figure 58.

![Figure 58. **SYNC** Interrupt](image-url)
Programming (continued)

8.5.1.2 I²C Mode

The DACx0501 digital interface is programmed to work in I²C mode when the logic level of the SPI2C pin is 1 at power up. In I²C mode, the DACx0501 have a 2-wire serial interface: SCL, SDA, and one address pin, A0, as shown in the Pin Configuration and Functions section. The I²C bus consists of a data line (SDA) and a clock line (SCL) with pull-up structures. When the bus is idle, both the SDA and SCL lines are pulled high. All the I²C-compatible devices connect to the I²C bus through the open-drain I/O pins, SDA and SCL.

The I²C specification states that the device that controls communication is called a master, and the devices that are controlled by the master are called slaves. The master device generates the SCL signal. The master device also generates special timing conditions (start condition, repeated start condition, and stop condition) on the bus to indicate the start or stop of a data transfer. Device addressing is completed by the master. The master device on an I²C bus is typically a microcontroller or DSP. The DACx0501 operate as a slave device on the I²C bus. A slave device acknowledges master commands, and upon master control, receives or transmits data.

Typically, the DACx0501 operate as a slave receiver. A master device writes to the DACx0501, a slave receiver. However, if a master device requires the DACx0501 internal register data, the DACx0501 operate as a slave transmitter. In this case, the master device reads from the DACx0501 According to I²C terminology, read and write refer to the master device.

The DACx0501 are slave devices that support the following data transfer modes:

1. Standard mode (100 kbps)
2. Fast mode (400 kbps)
3. Fast mode plus (1.0 Mbps)

The data transfer protocol for standard and fast modes is exactly the same; therefore, these modes are referred to as F/S-mode in this document. The fast-mode plus (FM+) protocol is supported in terms of data transfer speed, but not output current. The low-level output current would be 3 mA, similar to the case of standard and fast modes. The DACx0501 support 7-bit addressing. The 10-bit addressing mode is not supported. These devices support the general call reset function. Send the following sequence to initiate a software reset within the device: Start/Repeated Start, 0x00, 0x06, Stop. The reset is asserted within the device on the falling edge of the ACK bit, following the second byte.

Other than specific timing signals, the I²C interface works with serial bytes. At the end of each byte, a ninth clock cycle generates and detects an acknowledge signal. Acknowledge is when the SDA line is pulled low during the high period of the ninth clock cycle. A not-acknowledge is when the SDA line is left high during the high period of the ninth clock cycle as shown in Figure 59.

![Figure 59. Acknowledge and Not Acknowledge on the I²C Bus](image-url)
Programming (continued)

8.5.1.2.1 F/S Mode Protocol

1. The master initiates data transfer by generating a start condition. The start condition is when a high to-low transition occurs on the SDA line while SCL is high, as shown in Figure 60. All I²C-compatible devices recognize a start condition.

![Figure 60. Start and Stop Conditions](image)

2. The master then generates the SCL pulses, and transmits the 7-bit address and the read/write direction bit (R/W) on the SDA line. During all transmissions, the master makes sure that data are valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse, as shown in Figure 61. All devices recognize the address sent by the master and compare it to their internal fixed addresses. Only the slave device with a matching address generates an acknowledge by pulling the SDA line low during the entire high period of the ninth SCL cycle, as shown in Figure 59 by pulling the SDA line low during the entire high period of the ninth SCL cycle. Upon detecting this acknowledge, the master knows the communication link with a slave has been established.

![Figure 61. Bit Transfer on the I²C Bus](image)

3. The master generates further SCL cycles to transmit (R/W bit 0) or receive (R/W bit 1) data to the slave. In either case, the receiver must acknowledge the data sent by the transmitter. Therefore, the acknowledge signal can be generated by the master or by the slave, depending on which one is the receiver. The 9-bit valid data sequences consists of 8-data bits and 1 acknowledge-bit, and can continue as long as necessary.

4. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low to high while the SCL line is high (see Figure 60). This action releases the bus and stops the communication link with the addressed slave. All I²C-compatible devices recognize the stop condition. Upon receipt of a stop condition, the bus is released, and all slave devices then wait for a start condition followed by a matching address.
Programming (continued)

8.5.1.2.2  DACx0501 \(^2\)C Update Sequence

For a single update, the DACx0501 requires a start condition, a valid \(^2\)C address byte, a command byte, and two data bytes: the most significant data byte (MSDB), and least significant data byte (LSDB), as listed in Table 1.

<table>
<thead>
<tr>
<th>MSB</th>
<th>...</th>
<th>LSB</th>
<th>ACK</th>
<th>MSB</th>
<th>...</th>
<th>LSB</th>
<th>ACK</th>
<th>MSB</th>
<th>...</th>
<th>LSB</th>
<th>ACK</th>
</tr>
</thead>
</table>

After each byte is received, the DACx0501 acknowledge the byte by pulling the SDA line low during the high period of a single clock pulse, as shown in Figure 62. These four bytes and acknowledge cycles make up the 36 clock cycles required for a single update to occur. A valid \(^2\)C address byte selects the DACx0501 devices.

![Figure 62. \(^2\)C Bus Protocol](image)

The command byte sets the operational mode of the selected DACx0501 device. When the operational mode is selected by this byte, the DACx0501 must receive two data bytes, the most significant data byte (MSDB) and least significant data byte (LSDB), for a data update to occur. The DACx0501 devices perform an update on the falling edge of the acknowledge signal that follows the LSDB.

When using fast mode (clock = 400 kHz), the maximum DAC update rate is limited to 11.11 kSPS. Using the fast-mode plus (clock = 1 MHz), the maximum DAC update rate is limited to 27.77 kSPS. When a stop condition is received, the DACx0501 release the \(^2\)C bus and await a new start condition.
8.5.1.2.2.1 DACx0501 Address Byte

The address byte, as shown in Table 2, is the first byte received following the START condition from the master device. The first four bits (MSBs) of the address are factory preset to 1001. The next three bits of the address are controlled by the A0 pin. The A0 pin input can be connected to VDD, AGND, SCL, or SDA. The A0 pin is sampled during the first byte of each data frame to determine the address. The device latches the value of the address pin, and consequently, responds to that particular address according to Table 3.

Table 2. DACx0501 Address Byte

<table>
<thead>
<tr>
<th>ADDRESS TYPE</th>
<th>AD6</th>
<th>AD5</th>
<th>AD4</th>
<th>AD3</th>
<th>AD2</th>
<th>AD1</th>
<th>AD0</th>
<th>R/W</th>
</tr>
</thead>
<tbody>
<tr>
<td>General address</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td></td>
<td></td>
<td>R/W</td>
</tr>
</tbody>
</table>

See Table 3 (slave address column) 0 or 1

Table 3. Address Format

<table>
<thead>
<tr>
<th>SLAVE ADDRESS</th>
<th>A0 PIN</th>
</tr>
</thead>
<tbody>
<tr>
<td>1001 000</td>
<td>AGND</td>
</tr>
<tr>
<td>1001 001</td>
<td>VDD</td>
</tr>
<tr>
<td>1001 010</td>
<td>SDA</td>
</tr>
<tr>
<td>1001 011</td>
<td>SCL</td>
</tr>
</tbody>
</table>

8.5.1.2.2.2 DACx0501 Command Byte

The DACx0501 command byte (shown in Table 4) controls which command is executed and which register is being accessed when writing to or reading from the DACx0501 series.

Table 4. DACx0501 Command Byte

<table>
<thead>
<tr>
<th>B23</th>
<th>B22</th>
<th>B21</th>
<th>B20</th>
<th>B19</th>
<th>B18</th>
<th>B17</th>
<th>B16</th>
<th>COMMENT</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>NOOP</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>DEVID</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>SYNC</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>1</td>
<td>CONFIG</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>GAIN</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>TRIGGER</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>1</td>
<td>STATUS</td>
</tr>
<tr>
<td>0</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>1</td>
<td>0</td>
<td>0</td>
<td>0</td>
<td>DAC DATA</td>
</tr>
</tbody>
</table>
8.5.1.2.2.3 **DACx0501 Data Byte (MSDB and LSDB)**

The MSDB and LSDB contain the data that are passed to the register or registers specified by the command byte, as shown in Table 5. The DACx0501 update at the falling edge of the acknowledge signal that follows the LSDB[0] bit.

### Table 5. DACx0501 Data Byte

<table>
<thead>
<tr>
<th>COMMENT</th>
<th>COMMAND BITS</th>
<th>DATA BITS</th>
<th>LSDB</th>
</tr>
</thead>
<tbody>
<tr>
<td>NOOP</td>
<td>B19 B18 B17 B16</td>
<td>B15 B14 B13 B12 B11 B10 B9 B8 B7 B6 B5 B4 B3 B2 B1 B0</td>
<td>NOOP</td>
</tr>
<tr>
<td>DEVID</td>
<td>0 0 0 1</td>
<td>0 RESOLUTION 0 0 1 0 RSTSEL 0 0 1 0 1</td>
<td>DAC_SYNC_EN</td>
</tr>
<tr>
<td>SYNC</td>
<td>0 0 1 0</td>
<td>RESERVED</td>
<td>RESERVED</td>
</tr>
<tr>
<td>CONFIG</td>
<td>0 0 1 1</td>
<td>RESERVED</td>
<td>REF-PWDWN</td>
</tr>
<tr>
<td>GAIN</td>
<td>0 1 0 0</td>
<td>RESERVED</td>
<td>REF-DIV</td>
</tr>
<tr>
<td>TRIGGER</td>
<td>0 1 0 1</td>
<td>RESERVED</td>
<td>LDAC</td>
</tr>
<tr>
<td>STATUS</td>
<td>0 1 1 1</td>
<td>RESERVED</td>
<td>RESERVED</td>
</tr>
</tbody>
</table>
| DAC DATA | 1 0 0 0       | DAC-DATA [15:0] for 16-bit, DAC-DATA [13:0] for 14-bit, DAC-DATA [11:0] for 12-bit, left aligned
8.5.1.2.3 DACx0501 I²C Read Sequence

To read any register, use the following command sequence:

1. Send a start or repeated start command with a slave address and the R/W bit set to 0 for writing. The device acknowledges this event.
2. Send a command byte for the register to be read. The device acknowledges this event again.
3. Send a repeated start with the slave address and the R/W bit set to 1 for reading. The device acknowledges this event.
4. The device writes the MSDB byte of the addressed register. The master must acknowledge this byte.
5. Finally, the device writes out the LSDB of the register.

An alternative reading method allows for reading back the value of the last register written. The sequence is a start or repeated start with the slave address and the R/W bit set to 1, and the two bytes of the last register are read out. All the registers in DACx0501 family can be read out with the exception of SOFT-RESET register. Table 5 shows the read command set.

<table>
<thead>
<tr>
<th>S</th>
<th>MSB</th>
<th>...</th>
<th>R/W (0)</th>
<th>ACK</th>
<th>MSB</th>
<th>...</th>
<th>LSB</th>
<th>ACK</th>
<th>Sr</th>
<th>MSB</th>
<th>...</th>
<th>R/W (1)</th>
<th>ACK</th>
<th>MSB</th>
<th>...</th>
<th>LSB</th>
<th>ACK</th>
<th>MSB</th>
<th>...</th>
<th>LSB</th>
<th>NACK</th>
</tr>
</thead>
<tbody>
<tr>
<td>ADDRESS BYTE</td>
<td>COMMAND BYTE</td>
<td>Sr</td>
<td>ADDRESS BYTE</td>
<td>MSDB</td>
<td>LSDB</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>From Master</td>
<td>Slave</td>
<td>From Master</td>
<td>Slave</td>
<td>From Master</td>
<td>Slave</td>
<td>From Slave</td>
<td>Master</td>
<td>From Slave</td>
<td>Master</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>
8.6 Register Map

Table 7. Register Map

<table>
<thead>
<tr>
<th>OFFSET</th>
<th>REGISTER NAME</th>
<th>REGISTER DESCRIPTION</th>
<th>SECTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>0h</td>
<td>NOOP</td>
<td>No operation</td>
<td>NOOP Register</td>
</tr>
<tr>
<td>1h</td>
<td>DEVID</td>
<td>Device identification</td>
<td>DEVID Register</td>
</tr>
<tr>
<td>2h</td>
<td>SYNC</td>
<td>Synchronization</td>
<td>SYNC Register</td>
</tr>
<tr>
<td>3h</td>
<td>CONFIG</td>
<td>Configuration</td>
<td>CONFIG Register</td>
</tr>
<tr>
<td>4h</td>
<td>GAIN</td>
<td>Gain</td>
<td>GAIN Register</td>
</tr>
<tr>
<td>5h</td>
<td>TRIGGER</td>
<td>Trigger</td>
<td>TRIGGER Register</td>
</tr>
<tr>
<td>7h</td>
<td>STATUS</td>
<td>Status</td>
<td>STATUS Register</td>
</tr>
<tr>
<td>8h</td>
<td>DAC</td>
<td>Digital-to-analog converter</td>
<td>DAC Register</td>
</tr>
</tbody>
</table>

8.6.1 NOOP Register (offset = 0h) [reset = 0000h]

Figure 63. NOOP Register

<table>
<thead>
<tr>
<th>Bit</th>
<th>Field</th>
<th>Type</th>
<th>Reset</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-0</td>
<td>No operation</td>
<td>W</td>
<td>0h</td>
<td>No Operation command</td>
</tr>
</tbody>
</table>

8.6.2 DEVID Register (offset = 1h)

Figure 64. DEVID Register

<table>
<thead>
<tr>
<th>Bit</th>
<th>Field</th>
<th>Type</th>
<th>Reset</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>0</td>
<td>RESOLUTION</td>
<td>R</td>
<td>0000h (DAC80501)</td>
<td>DAC Resolution: 0000h (DAC80501 16-bit) 0001h (DAC70501 16-bit) 0020h (DAC60501 12-bit)</td>
</tr>
<tr>
<td></td>
<td>R-0000h (DAC80501)</td>
<td>R-0h</td>
<td>0-000h (DAC80501Z)</td>
<td></td>
</tr>
<tr>
<td></td>
<td>or 0001h (DAC70501)</td>
<td>R-1h</td>
<td>0-001h (DAC70501M)</td>
<td></td>
</tr>
<tr>
<td></td>
<td>or 0020h (DAC60501)</td>
<td>R-0h</td>
<td>0-020h (DAC60501M)</td>
<td></td>
</tr>
<tr>
<td>15-12</td>
<td>RESOLUTION</td>
<td>R</td>
<td>0000h (DAC80501)</td>
<td>DAC Resolution: 0000h (DAC80501 16-bit) 0001h (DAC70501 16-bit) 0020h (DAC60501 12-bit)</td>
</tr>
<tr>
<td></td>
<td>or 0001h (DAC70501)</td>
<td>R-1h</td>
<td>0-001h (DAC70501M)</td>
<td></td>
</tr>
<tr>
<td></td>
<td>or 0020h (DAC60501)</td>
<td>R-0h</td>
<td>0-020h (DAC60501M)</td>
<td></td>
</tr>
</tbody>
</table>

Table 9. DEVID Register Field Descriptions

<table>
<thead>
<tr>
<th>Bit</th>
<th>Field</th>
<th>Type</th>
<th>Reset</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>15</td>
<td>RESERVED</td>
<td>R</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>14-12</td>
<td>RESOLUTION</td>
<td>R</td>
<td>0000h (DAC80501)</td>
<td>DAC Resolution: 0000h (DAC80501 16-bit) 0001h (DAC70501 16-bit) 0020h (DAC60501 12-bit)</td>
</tr>
<tr>
<td></td>
<td>or 0001h (DAC70501)</td>
<td>R-1h</td>
<td>0-001h (DAC70501M)</td>
<td></td>
</tr>
<tr>
<td></td>
<td>or 0020h (DAC60501)</td>
<td>R-0h</td>
<td>0-020h (DAC60501M)</td>
<td></td>
</tr>
<tr>
<td>11-8</td>
<td>RESERVED</td>
<td>R</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>7</td>
<td>RSTSEL</td>
<td>R</td>
<td>0h</td>
<td>DAC Power on Reset: 0h (DAC80501Z reset to zero scale) 1h (DAC80501M reset to midscale)</td>
</tr>
<tr>
<td>6-0</td>
<td>RESERVED</td>
<td>R</td>
<td>015h</td>
<td>RESERVED</td>
</tr>
</tbody>
</table>
8.6.3  SYNC Register (offset = 2h) [reset = 0000h]

Figure 65.  SYNC Register

<table>
<thead>
<tr>
<th>BIT</th>
<th>FIELD</th>
<th>TYPE</th>
<th>RESET</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-1</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>0</td>
<td>DAC_SYNC_EN</td>
<td>RW</td>
<td>0h</td>
<td>When set to 1, the DAC output is set to update in response to an LDAC trigger (synchronous mode). When cleared to 0, the DAC output is set to update immediately (asynchronous mode), default.</td>
</tr>
</tbody>
</table>

Table 10.  SYNC Register Field Descriptions

8.6.4  CONFIG Register (offset = 3h) [reset = 0000h]

Figure 66.  CONFIG Register

<table>
<thead>
<tr>
<th>BIT</th>
<th>FIELD</th>
<th>TYPE</th>
<th>RESET</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-9</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>8</td>
<td>REF_PWDWN</td>
<td>RW</td>
<td>0h</td>
<td>When set to 1, this bit disables the device internal reference.</td>
</tr>
<tr>
<td>7-1</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>0</td>
<td>DAC_PWDWN</td>
<td>RW</td>
<td>0h</td>
<td>When set to 1, the DAC in power-down mode and the DAC output is connected to GND through a 1-kΩ internal resistor.</td>
</tr>
</tbody>
</table>

Table 11.  CONFIG Register Field Descriptions
8.6.5  GAIN Register (offset = 4h) [reset = 0001h]

Table 12. GAIN Register Field Descriptions

<table>
<thead>
<tr>
<th>BIT</th>
<th>FIELD</th>
<th>TYPE</th>
<th>RESET</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-9</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>8</td>
<td>REF-DIV</td>
<td>RW</td>
<td>0h</td>
<td>The reference voltage to the device (either from the internal or external reference) can be divided by a factor of two by setting the REF-DIV bit to 1. Make sure to configure REF-DIV so that there is sufficient headroom from VDD to the DAC operating reference voltage. Improper configuration of the reference divider triggers a reference alarm condition. In the case of an alarm condition, the reference buffer is shut down, and all the DAC outputs go to 0 V. The DAC data registers are unaffected by the alarm condition, and thus enable the DAC output to return to normal operation after the reference divider is configured correctly. When REF-DIV set to 1, the reference voltage is internally divided by a factor of 2. When REF-DIV is cleared to 0, the reference voltage is unaffected.</td>
</tr>
<tr>
<td>7-1</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>0</td>
<td>BUFF-GAIN</td>
<td>RW</td>
<td>1h</td>
<td>When set to 1, the buffer amplifier for corresponding DAC has a gain of 2. When cleared to 0, the buffer amplifier for corresponding DAC has a gain of 1.</td>
</tr>
</tbody>
</table>

8.6.6  TRIGGER Register (offset = 5h) [reset = 0000h]

Table 13. TRIGGER Register Field Descriptions

<table>
<thead>
<tr>
<th>BIT</th>
<th>FIELD</th>
<th>TYPE</th>
<th>RESET</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-5</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>4</td>
<td>LDAC</td>
<td>W</td>
<td>0h</td>
<td>Set this bit to 1 to synchronously load the DAC in synchronous mode. This bit is self resetting.</td>
</tr>
<tr>
<td>3-0</td>
<td>SOFT-RESET [3:0]</td>
<td>W</td>
<td>0h</td>
<td>When set to the reserved code of 1010, this bit resets the device to the default state. These bits are self resetting.</td>
</tr>
</tbody>
</table>
8.6.7 STATUS Register (offset = 7h) [reset = 0000h]

Figure 69. STATUS Register

<table>
<thead>
<tr>
<th>Bit</th>
<th>Field</th>
<th>Type</th>
<th>Reset</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-1</td>
<td>RESERVED</td>
<td>RW</td>
<td>0h</td>
<td>RESERVED</td>
</tr>
<tr>
<td>0</td>
<td>REF-ALARM</td>
<td>R</td>
<td>0</td>
<td>REF-ALARM bit. Reads 1 when the difference between the reference and supply pins is below a minimum analog threshold. Reads 0 otherwise. When 1, the reference buffer is shut down, and the DAC outputs are all zero volts. The DAC codes are unaffected, and the DAC output returns to normal when the difference is above the analog threshold.</td>
</tr>
</tbody>
</table>

8.6.8 DAC Register (offset = 8h) [reset = 0000h for DACx0501Z or reset = 8000h for DACx0501M]

Figure 70. DAC Register

<table>
<thead>
<tr>
<th>Bit</th>
<th>Field</th>
<th>Type</th>
<th>Reset</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>15-0</td>
<td>DAC-DATA</td>
<td>RW</td>
<td>0000h</td>
<td>DAC-DATA [15:0]</td>
</tr>
<tr>
<td></td>
<td>[15:0]</td>
<td></td>
<td>8000h</td>
<td>8000h for DACx0501M</td>
</tr>
<tr>
<td></td>
<td>[13:0]</td>
<td></td>
<td>0</td>
<td>DACx0501Z</td>
</tr>
<tr>
<td></td>
<td>[11:0]</td>
<td></td>
<td>0</td>
<td>DACx0501M</td>
</tr>
<tr>
<td></td>
<td>[9:0]</td>
<td></td>
<td>0</td>
<td>DAC60501</td>
</tr>
<tr>
<td></td>
<td>[7:0]</td>
<td></td>
<td>0</td>
<td>DAC60501</td>
</tr>
<tr>
<td></td>
<td>[5:4]</td>
<td></td>
<td>0</td>
<td>DAC60501</td>
</tr>
<tr>
<td></td>
<td>[3:2]</td>
<td></td>
<td>0</td>
<td>DAC60501</td>
</tr>
<tr>
<td></td>
<td>[1:0]</td>
<td></td>
<td>0</td>
<td>DAC60501</td>
</tr>
</tbody>
</table>
9 Application and Implementation

NOTE
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information
Applications that incorporate analog circuits often require trimming, control, biasing, or a combination of all three. These functions require high-accuracy, simple-to-implement compact solutions. The DACx0501 family of precision DACs are an excellent choice for such applications. The DACx0501 tiny package, high resolution, and simple interface makes these devices suitable for applications such as offset and gain control, VCO tuning, programmable reference, and more. With the aforementioned features, this family of DACs caters to a wide range of end equipment, such as battery testers, communications equipment, factory automation and control, test and measurement, and more.

9.2 Typical Application
End equipment, such as oscilloscopes, battery test equipment, and other lab instruments require precision calibration and control signals to tune the system accuracy. Precision DACs are typically used to generate these signals. The complexity and accuracy of these systems are driving the need for multiple precision signals to be generated in the system. The common approach for generating these signal is by using a multichannel DAC. An alternative way to generate these signal is to use a single channel DAC with sample and hold circuit to produce multichannel output. Using this approach, the users can generate customized number of channel instead of using a fixed number of channels available in multichannel DACs.

Figure 71. Multichannel Sample-and-Hold Circuit
Typical Application (continued)

9.2.1 Design Requirements

The design requirements for this circuit are as follows:

• Output range: 0-V to 5-V
• Channels: 10
• Output offset error: ±3-mV

9.2.2 Detailed Design Procedure

A basic sample-and-hold circuit consists of a voltage source (DAC in this case), a switch, a capacitor, and a buffer. As the name implies, this circuit has two modes of operation: sample and hold. In sample mode, the switch is closed connecting the DAC output to the hold capacitor, \( C_H \). In hold mode, the switch opens, disconnecting the DAC output from \( C_H \). Thus, the final output is held to the sampled value because of the charge stored on hold capacitor \( C_H \). The output buffer is needed for delivering the required current. In a practical circuit, the switch leakage and the amplifier bias current make the capacitor drift from the stored value. Therefore, the sample-and-hold circuit must be refreshed, even if the DAC value does not change. The key design parameters of a sample-and-hold circuit are charge injection and voltage droop.

9.2.2.1 Charge Injection

During the sample-to-hold transition, a small amount of charge is injected onto the hold capacitor, mostly because of the stray capacitance of the switch that creates small level changes when transitioning between states. The resulting dc offset is typically referred to as pedestal error. This error contributes to the offset error of the system. The pedestal error, \( \Delta V_{OUT}\), is the measured offset voltage resulting from charge injection when the switch transitions to hold state. \( \Delta V_{OUT}\) is related to charge injection through Equation 2.

\[
\Delta V_{OUT} = \frac{Q}{C}
\]

where

• \( Q \) is the injected charge coulombs.
• \( C \) is the value of the hold capacitor in farads. (2)

In most solid-state switch data sheets, charge injection is graphed with respect to supply voltage, analog input, or temperature. A charge injection value of 3-pC is typical in many solid-state switches under the conditions: 25°C, 5-V supply, and 0-V analog input.

9.2.2.2 Voltage Droop

In hold mode, the voltage across \( C_H \) that should have remained constant suffers a droop because of the leakage resistance of the switch and the amplifier bias current. A simplified equation for calculating the voltage droop is given by Equation 3

\[
\frac{\Delta V}{\Delta t} = \frac{(I_{LEAK} + I_{BIAS})}{C}
\]

where

• \( I_{LEAK} \) is the leakage current through the switch in amperes.
• \( I_{BIAS} \) is the bias current of the amplifier in amperes.
• \( C \) is the value of the hold capacitance in farads. (3)
Typical Application (continued)

9.2.2.3 Output Offset Error

The output offset error of an sample-and-hold channel is the cumulative error contributed by the DAC offset error, amplifier offset error, and sample-and-hold pedestal error due to charge injection. The amplifier offset error can be made negligible by choosing a low-offset amplifier such as the OPA4317. The OPA4317 has an offset error of 0.1-mV max. The DAC80501 has a max offset error of ±1.5-mV. Thus, in order to achieve an total offset error less than ±3-mV, the offset error contributed by the sample-and-hold circuit must be limited to ±1.5-mV.

Considering the bias current of 300-pA in the OPA4317, and a typical switch leakage current of 1-nA, a 2-nF hold capacitor results in a droop rate of 0.65 V/s. When the sample-and-hold circuit refreshes at a rate of more than 100-µs, the voltage droop is 65-µV. This small offset error can be ignored for the simplicity of calculation. Thus, the only contributor to the sample-and-hold offset error is the pedestal error. For a charge injection of 3-pC and a pedestal error of 1.5-mV, the value of the hold capacitor is calculated as 2-nF, according to Equation 2. A capacitive load of 2-nF can be handled by the DAC80501. The switch on resistance and optional series resistance $R_S$ further helps in the stability of the DAC output amplifier. $R_S$ can be omitted for better settling time.

9.2.2.4 Switch Selection

The switch in the design must feature low on-state resistance and low off leakage, and must conduct rail-to-rail analog signals. Very low charge injection is also a primary factor for selecting the switch. The TS12A4515 are single pole and single throw (SPST), low-voltage, single-supply CMOS analog switches with 20-Ω on-state resistance, 3 pC of charge-injection (5-V supply), and an off-Leakage current value of 1 nA.

9.2.2.5 Amplifier Selection

The key parameters for the amplifier in this system are low offset voltage and low input bias current. The OPA4317 is a quad amplifier that has a max offset voltage of 100 µV and a max bias current of 300 pA. As a result of the quad package, less board area is used.

9.2.2.6 Hold Capacitor Selection

Use a hold capacitor that has high insulation resistance, low temperature coefficient, and low dielectric absorption. Low temperature coefficient NP0/C0G ceramic capacitors are a great choice for this purpose. As calculated in Equation 2, a 2-nF capacitor provides a total offset error of ±3 mV per channel.

9.2.3 Application Curves

![Figure 72. Sample-and-Hold Pedestal Error With 3-pC Charge Injection](image-url)
10 Power Supply Recommendations

The DACx0501 operate within the specified VDD supply range of 2.7 V to 5.5 V. The DACx0501 do not require specific supply sequencing.

The VDD supply must be well regulated and low noise. Switching power supplies and DC/DC converters often have high-frequency glitches or spikes riding on the output voltage. In addition, digital components create similar high-frequency spikes. This noise can easily couple into the DAC output voltage through various paths between the power connections and analog output. To further minimize noise from the power supply, include a 1-µF to 10-µF capacitor and 0.1-µF bypass capacitor. The current consumption on the VDD pin, the short-circuit current limit, and the load current for the device is listed in the Electrical Characteristics section. The power supply must meet the aforementioned current requirements.

11 Layout

11.1 Layout Guidelines

A precision analog component requires careful layout. The following list provides some insight into good layout practices.

- Bypass the VDD to ground with a low ESR ceramic bypass capacitor. The typical recommended bypass capacitance is 0.1-µF to 0.22-µF ceramic capacitor, with a X7R or NP0 dielectric.
- Place power supplies and REF bypass capacitors close to the pins to minimize inductance and optimize performance.
- Use a high-quality, ceramic-type NP0 or X7R for optimal performance across temperature, and a very low dissipation factor.
- The digital and analog sections must have proper placement with respect to the digital pins and analog pins of the DACx0501 devices. The separation of analog and digital blocks minimizes coupling into neighboring blocks, as well as interaction between analog and digital return currents.

11.2 Layout Example

![Figure 73. Layout Example](image-url)
12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation
For related documentation see the following: Texas Instruments, *DAC80501EVM user's guide*

12.2 Related Links
Table 16 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

<table>
<thead>
<tr>
<th>PARTS</th>
<th>PRODUCT FOLDER</th>
<th>SAMPLE &amp; BUY</th>
<th>TECHNICAL DOCUMENTS</th>
<th>TOOLS &amp; SOFTWARE</th>
<th>SUPPORT &amp; COMMUNITY</th>
</tr>
</thead>
<tbody>
<tr>
<td>DAC80501</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
</tr>
<tr>
<td>DAC70501</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
</tr>
<tr>
<td>DAC60501</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
<td>Click here</td>
</tr>
</tbody>
</table>

12.3 Receiving Notification of Documentation Updates
To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.4 Support Resources
The following links connect to TI community resources. Linked contents are provided “AS IS” by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI’s Terms of Use.

**TI E2E™ Online Community** *TI’s Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI’s Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.5 Trademarks
E2E is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

12.6 Electrostatic Discharge Caution
This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.7 Glossary
SLYZ022 — *TI Glossary.*
This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.
## PACKAGING INFORMATION

<table>
<thead>
<tr>
<th>Orderable Device</th>
<th>Status</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan</th>
<th>Lead/Ball Finish</th>
<th>MSL Peak Temp</th>
<th>Op Temp (°C)</th>
<th>Device Marking</th>
<th>Samples</th>
</tr>
</thead>
<tbody>
<tr>
<td>DAC60501MDGSR</td>
<td>PREVIEW</td>
<td>VSSOP</td>
<td>DGS</td>
<td>10</td>
<td>3000</td>
<td>TBD</td>
<td>Call Ti</td>
<td>Call Ti</td>
<td>-40 to 125</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DAC60501MDGST</td>
<td>PREVIEW</td>
<td>VSSOP</td>
<td>DGS</td>
<td>10</td>
<td>250</td>
<td>TBD</td>
<td>Call Ti</td>
<td>Call Ti</td>
<td>-40 to 125</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DAC60501MDQFR</td>
<td>ACTIVE</td>
<td>WSON</td>
<td>DQF</td>
<td>8</td>
<td>3000</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>CU NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>-40 to 125</td>
<td>651M</td>
<td></td>
</tr>
<tr>
<td>DAC60501MDQFT</td>
<td>ACTIVE</td>
<td>WSON</td>
<td>DQF</td>
<td>8</td>
<td>250</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>CU NIPDAU</td>
<td>Level-2-260C-1 YEAR</td>
<td>-40 to 125</td>
<td>651M</td>
<td></td>
</tr>
<tr>
<td>DAC60501ZDGSR</td>
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(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of \(\leq 1000\text{ppm}\) threshold. Antimony trioxide based flame retardants must also meet the \(\leq 1000\text{ppm}\) threshold requirement.

(3) **MSL, Peak Temp.** - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "−" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) **Lead/Ball Finish** - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

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### TAPE AND REEL INFORMATION

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#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

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*All dimensions are nominal*
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187, variation BA.
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.
MECHANICAL DATA

DQF (S-PWSON-N8) PLASTIC SMALL OUTLINE NO-LEAD

PIN 1 INDEX AREA
TOP AND BOTTOM

0.70
0.50

0.60
0.40

0.30
0.20

0.50

0.10
C A B
0.05
C

NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. SON (Small Outline No–Lead) package configuration.

4209902/B 06/12

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NOTES:

A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
E. Customers should contact their board fabrication site for solder mask tolerances.
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